

**SINGAPORE LABORATORY
ACCREDITATION SCHEME**



Number : **LA-2002-0265-C**

Date of Issue : **11 November 2022**

Date of Expiry : **10 November 2026**

Certificate of Accreditation

This certifies that

**Cairnhill Metrology Pte Ltd
5 Jalan Kilang Barat
#07-05/06 Petro Centre
Singapore 159349**

is accredited by the Singapore Accreditation Council to

ISO / IEC 17025 : 2017

for specific scope within the field of

Calibration & Measurement

as detailed in the attached schedule.

A handwritten signature in black ink, appearing to be "XIN", written over a horizontal line.

Chairman

This Certificate is awarded subject to the organisation's compliance with the stated criteria and terms and conditions laid down by the Singapore Accreditation Council.

This Certificate may not be reproduced except with the written permission of the Chairman.

Schedule

Cairnhill Metrology Pte Ltd
5 Jalan Kilang Barat
#07-05/06 Petro Centre
Singapore 159349

Certificate No. : LA-2002-0265-C
Issue No. : 20
Date : 09 February 2025
Expiry of Certificate : 10 November 2026
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FIELD OF TESTING : Calibration and Measurement

MEASURED QUANTITIES / RANGE / INSTRUMENTS TO BE CALIBRATED	METHOD OF CALIBRATION / INSTRUMENTS USED	CALIBRATION & MEASUREMENT CAPABILITY (CMC *)
<p>1. Profile Projector Travel 300 mm x 200 mm Resolution : 1 to 5 μm</p> <p>a) Starrett Measurement Projector b) Generic Brands</p>	In-house Calibration Procedure (WI 15-10, V7)	2.0 μm
<p>2. Accretch TSK Roundness Measurement Machine Probing diameter up to 450 mm Resolution : 0.0001 μm</p> <p><u>Feature examined</u> Roundness Parallelism</p>	In-house Calibration Procedure (WI 15-01, V7)	0.006 μm 0.3 μm
<p>3. Accretch TSK Contour Testing Tracing Range X and Z up to 200 mm and 50 mm respectively Resolution : 0.1 to 1 μm</p> <p><u>Feature Examined</u> Profile: Ball Diameter Step Height: Z-Axis</p>	In-house Calibration Procedure (WI 15-02, V7)	0.5 μm 0.5 μm

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MEASURED QUANTITIES / RANGE / INSTRUMENTS TO BE CALIBRATED	METHOD OF CALIBRATION / INSTRUMENTS USED	CALIBRATION & MEASUREMENT CAPABILITY (CMC *)
4. Accretech TSK Surface Roughness Testing (Contact Type) Measuring Range : 80 μm Resolution : 0.001 μm <u>Feature examined</u> Roughness, Ra	In-house Calibration Procedure (WI 15-03, V7)	0.06 μm
5. Co-ordinate Measuring Machine (Contact Type) a) Accretech TSK Using gauge block Up to 500 mm > 500 mm to 600 mm > 600 mm to 1000 mm b) Generic Brands Using gauge block up to 1000mm	In-house Calibration Procedure (WI 15-05, V7)	0.6 μm 0.7 μm 0.8 μm 1.7 μm
6. Optical / Non-Contact Co-ordinate Measuring Machine Starrett Non-Contact CMM Range: X \leq 350 mm Y \leq 350 mm Z \leq 200 mm Resolution: 0.1 to 0.5 μm X and Y- axes Z-axis (For Contact Probe)	In-house Calibration Procedure (WI 15-11, V1)	2.0 μm 0.4 μm
7. Universal Length Metroscope ULM Calibration Range of Measuring Headstock: X \leq 100 mm Resolution: 0.01 μm	In-house Calibration Procedure (WI 15-08, V7)	0.21 μm

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MEASURED QUANTITIES / RANGE / INSTRUMENTS TO BE CALIBRATED	METHOD OF CALIBRATION / INSTRUMENTS USED	CALIBRATION & MEASUREMENT CAPABILITY (CMC *)																								
<p>8. Weighing Scales</p> <p>Anritsu Checkweigher (Static, On-site)</p> <table><tr><td><u>Resolution</u></td><td><u>Range</u></td><td></td></tr><tr><td>Up to 0.01 g</td><td>0 to 600 g</td><td>0.02 g</td></tr><tr><td>0.02 g ~ 0.05 g</td><td>0 to 3000 g</td><td>0.07 g</td></tr><tr><td>0.1 g</td><td>0 to 3000 g</td><td>0.2 g</td></tr><tr><td>0.2 g ~ 1 g</td><td>0 to 15000 g</td><td>2 g</td></tr><tr><td>2 g</td><td>0 to 25000 g</td><td>4 g</td></tr><tr><td>2 g</td><td>0 to 35000 g</td><td>18 g</td></tr><tr><td>2 g</td><td>0 to 60000 g</td><td>15 g</td></tr></table>	<u>Resolution</u>	<u>Range</u>		Up to 0.01 g	0 to 600 g	0.02 g	0.02 g ~ 0.05 g	0 to 3000 g	0.07 g	0.1 g	0 to 3000 g	0.2 g	0.2 g ~ 1 g	0 to 15000 g	2 g	2 g	0 to 25000 g	4 g	2 g	0 to 35000 g	18 g	2 g	0 to 60000 g	15 g	<p>In-house Calibration Procedure (WI 15-16, V1)</p>	
<u>Resolution</u>	<u>Range</u>																									
Up to 0.01 g	0 to 600 g	0.02 g																								
0.02 g ~ 0.05 g	0 to 3000 g	0.07 g																								
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2 g	0 to 35000 g	18 g																								
2 g	0 to 60000 g	15 g																								
<p>9. (#) Dimensional Measurement Coordinate Measuring Machine (CMM), (Lab)</p> <p>Length: Up to 200 mm >200 mm to 1200 mm</p>	<p>In-house Calibration Procedure (WI 15-23, V1)</p>	<p>0.0008 mm Q [0.0007 mm, 2.9E-06 L], L in mm</p>																								

* CMC is expressed as an expanded uncertainty estimated at a level of confidence of approximately 95%.

Calibration Facility located at: 5 Jalan Kilang Barat, #01-02 Petro Centre, Singapore 159349.

Approved Signatories:

Mr Lim Seng Hoo	- For Items 1 to 7
Mr Tan Peng	- For Items 1 to 7
Mr Loh Kum Seng	- For Items 1 to 7
Mr Wong Kian Wah	- For Items 1 to 5, 7 & 8
Mr Tan Wei Hong Dennis	- For Item 8
Mr Ng Shyh Yu	- For Item 9
Mr Lim Chen Kee	- For all accredited calibrations

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Branch Offices

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LA-2002-0265-C-1

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LA-2002-0265-C-2

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1780 Philippines

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Note:

This laboratory is accredited in accordance with the recognised International Standard ISO/IEC 17025. A laboratory's fulfilment of the requirements of ISO/IEC 17025 means the laboratory meets both the technical competence requirements and **management system requirements** that are necessary for it to consistently deliver technically valid calibration results. The **management system requirements** in ISO/IEC 17025 are written in language relevant to laboratory operations and operate generally in accordance with the principles of ISO 9001.